From the Editor

Timing is Everything



With this issue of *Microscopy Today* I once again follow in the footsteps of my longtime friend and mentor, Charles Lyman. In 2005, as I was finishing my second stint as Program Chair for Microscopy & Microanalysis meetings, Charlie was the Editor-in-Chief of *Microscopy and Microanalysis* (*MAM*), MSA's peer-reviewed journal. At that time *MAM* was a relatively young journal, and Charlie was building it into the leading international journal that it currently is. As I finished my Program Chair duties, Charlie asked me to be Guest Editor for a special issue of the journal on "Imaging the Cardiovascular System." As I finished my guest editorship, Charlie realized the word "no" was absent from my vocabulary and asked me to join the editorial staff of the journal as an Applications Editor for Biological Sciences. I graciously accepted the invitation.

In 2008 Ron Anderson, the then-Editor-in-Chief of *Microscopy Today* (*MTO*), decided to retire from this position, and MSA council appointed Charlie Editor-in-Chief starting in 2009. This left the role of *MAM* journal editor open. The MSA Council appointed me as *MAM* journal Editor-in-Chief in January of 2009, and I subsequently held that position through 2016 when I stepped down to run for the position of MSA President-Elect. Now, as I finish my presidential duties, and Charlie retires as the chief editor of *MTO*, I once again follow Charlie's lead and take on the task of building on the outstanding job he did as the Editor-in-Chief of *Microscopy Today*.

I am fortunate in two key elements as I assume my duties as the Editor-in-Chief of *Microscopy Today*. First, as he did when I followed him as the Editor-in-Chief of *Microscopy and Microanalysis*, Charlie leaves me with a very successful and internationally recognized publication at the top of its field. My primary task over the next few issues is to continue to build on this success—and not mess things up. This leads me to the second thing that I am very fortunate in having: a dedicated editorial team and staff, many of whom I have had the pleasure of working with over the last decade. With the help and guidance of those named in the column to the right of this editorial, I am sure *Microscopy Today* will continue to grow and become even more successful. As readers of this magazine, I hope all of you will feel free to provide guidance. Please let me know how I can enhance the content in these pages to best serve the microscopy community.

Robert L. Price Editor-in-Chief

Publication Objective: to provide information of interest to microscopists.

Microscopy Today is a controlled-circulation trade magazine owned by the Microscopy Society of America that is published six times a year in the odd months. Editorial coverage spans all microscopy techniques including light microscopy, scanning probe microscopy, electron microscopy, ion-beam techniques, and the wide range of microanalytical methods. Readers and authors come from both the life sciences and the physical sciences. The typical length of an article is about 2,000 words plus figures and tables; feature articles are longer. Interested authors should consult "Instructions for Contributors" on the Microscopy Today website: www.microscopy-today.com.

ISSN 1551-9295

Disclaimer

The Microscopy Society of America and the editors cannot be held responsible for opinions, errors, or for any consequences arising from the use of information contained in *Microscopy Today*. The appearance of advertising in *Microscopy Today* does not constitute an endorsement or approval by the Microscopy Society of America of any claims or information found in the advertisements. By submitting a manuscript to *Microscopy Today*, the author warrants that the article is original or that the author has written permission to use copyrighted material published elsewhere. While the contents of this magazine are believed to be accurate at press time, neither the Microscopy Society of America, the editors, nor the authors can accept legal responsibility for errors or omissions.

© Copyright 2020 by the Microscopy Society of America. All rights reserved.



Editorial Staff

Robert L. Price, Editor-in-Chief bob.price@uscmed.sc.edu (803) 216-3824

Gennifer Levey, Production Manager glevey@meridianartpro.com (212) 780-0315

Beverly Maleeff, Administrative Editor bev@alumni.psu.edu

Charles E. Lyman, Senior Editor charles.lyman@lehigh.edu Phil Oshel, Senior Editor oshellpe@cmich.edu

Stephen Carmichael, Columnist carmichael.stephen@mayo.edu

John Shields, Columnist johnshields59@gmail.com

Eric Clark, Pioneers Editor eclark@magnet.fsu.edu

Richard Edelmann, Education Editor edelmare@miamioh.edu

Deb Kelly, Microscopy 101 Editor debkelly@psu.edu

Paul Webster, Calendar Editor p.webster@oak-crest.org

Nikolaus Cordes, Digital Content Editor nikolaus.cordes@inl.gov

Thomas Kelly, Chief Innovation Judge Thomas.kelly@ametek.com

Robert Simmons, Chief Micrograph Judge robert.simmons@briarwillow.com

Advertising Sales

M.J. Mrvica Associates, Inc. 2 West Taunton Avenue, Berlin, NJ 08009 mjmrvica@mrvica.com (856) 768-9360

Kelly Miller, Account Manager kmiller@mrvica.com

Magazine website:

http://www.microscopy-today.com Free subscriptions are available.

Publishe

Cambridge University Press One Liberty Plaza, 20th Floor New York, New York 10006 (212) 337-5000

Circulation: 18,000

Editorial Board

Nasim Alem, Penn State University Arlan Benscoter, Lehigh University John Bozzola, Southern Illinois University Peter Crozier, Arizona State University Vinayak Dravid, Northwestern University David Grubb, Cornell University Bryan Huey, University of Connecticut Heather Lowers, U.S. Geological Survey John Mackenzie, North Carolina State Univ. Paul Maddox, U. of North Carolina-Chapel Hill Ania Majewska, U. Rochester Med School Joseph Michael, Sandia National Labs Caroline Miller, Indiana University Brian M. Patterson, Los Alamos National Lab John Reffner, John Jay College, SUNY lan Robertson, University of Wisconsin Phillip Russell, Appalachian State University Bradley Thiel, SUNY Polytechnic Institute Simon Watkins, University of Pittsburgh Cynthia Zeissler, Nat. Inst. of Stds. and Tech. (NIST)